

# CLC007 Serial Digital Cable Driver with Dual Complementary Outputs

## **General Description**

National's Comlinear CLC007 is a monolithic, high-speed cable driver designed for the SMPTE 259M serial digital video data transmission standard. The CLC007 drives  $75\Omega$  transmission lines (Belden 8281 or equivalent) at data rates up to 400 Mbps. Controlled output rise and fall times (750 ps typical) minimize transition-induced jitter. The output voltage swing, typically 1.65V, set by an accurate, low-drift internal bandgap reference, delivers an 800 mV swing to backmatched and terminated  $75\Omega$  cable.

The CLC007's class AB output stage consumes less power than other designs, 195 mW with all outputs terminated, and requires no external bias resistors. The differential inputs accept a wide range of digital signals from 200 mV<sub>P-P</sub> to ECL levels within the specified common-mode limits. All this make the CLC007 an excellent general purpose high speed driver for digital applications.

The CLC007 is powered from a single +5V or -5.2V supply and comes in an 8-pin SOIC package.

## **Key Specifications**

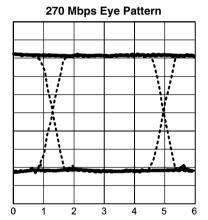
- 650 ps rise and fall times
- Data rates to 400 Mbps
- 2 sets of complimentary outputs
- 200 mV differential input
- Low residual jitter (25 ps<sub>pp</sub>)

### **Features**

- No external pull-down resistors
- Differential input and output
- Low power dissipation
- Single +5V or -5.2V supply
- Replaces GS9007 in most applications

## **Applications**

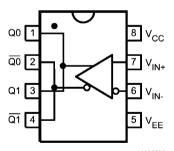
- Digital routers and distribution amplifiers
- Coaxial cable driver for digital transmission line
- Twisted pair driver
- Digital distribution amplifiers
- SMPTE, Sonet/SDH, and ATM compatible driver
- Buffer applications



10008501

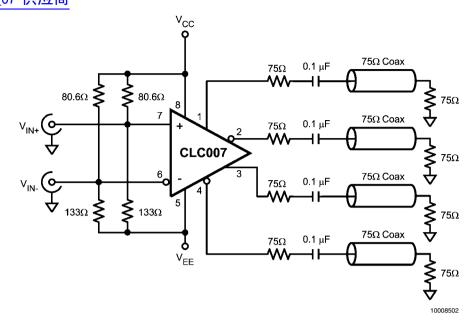
# **Connection Diagram (8-Pin SOIC)**

TIME (1 ns/Div)



Order Number CLC007BM
See NS Package Number M08A

## Typical Application 查询"CLC007\_07"供应商



# Absolute Maximum Ratings (Note 1)

If Military Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

6V Supply Voltage **Output Current** 30 mA +125°C Maximum Junction Temperature Storage Temperature Range -65°C to +150°C

Lead Temperature

+300°C (Soldering 10 Second) 1000V

ESD Rating (Human body Model)

Package Thermal Resistance

 $\theta_{JA}$  8-pin SOIC +160°C θ<sub>IC</sub> 8-pin SOIC +105°C/W

Reliability Information

**MTTF** 254 Mhr

# **Recommended Operating Conditions**

+4.5V to +5.5V Supply Voltage (V<sub>CC</sub> - V<sub>FF</sub>)

## **Electrical Characteristics**

 $(V_{CC} = 0V, V_{FF} = -5V; unless otherwise specified).$ 

Parameter	Conditions	Typ +25°C	Min/Max +25°C	Min/Max 0°C to +70°C	Min/Max -40°C to +85°C	Units
STATIC PERFORMANCE						
Supply Current, Loaded	(Note 5)	39	_	_	_	mA
Supply Current, Unloaded	(Note 3)	34	28/45	26/47	26/47	mA
Output HIGH Voltage (V <sub>OH</sub> )	(Note 3)	-1.7	-2.0/1.4	-2.0/1.4	-2.0/1.4	V
Output Low Voltage (V <sub>OL</sub> )	(Note 3)	-3.3	-3.6/3.0	-3.6/3.0	-3.6/3.0	V
Input Bias Current		10	30	50	50	μA
Output Swing	(Note 3)	1.65	1.55/1.75	1.53/1.77	1.51/1.79	V
Common Mode Input Range Upper Limit		-0.7	-0.8	-0.8	-0.8	V
Common Mode Input Range Lower Limit  Minimum Differential Input Swing		-2.6	-2.5	-2.5	-2.5	V
		200	200	200	200	mV
Power Supply Rejection Ratio (Note 3)		26	20	20	20	dB
AC PERFORMANCE						
Output Rise and Fall Time	(Notes 3, 4, 5)	650	425/955	400/1100	400/1100	ps
Overshoot		5				%
Propagation Delay		1.0				ns
Duty Cycle Distortion		50				ps
Residual Jitter		25	–	_	_	ps <sub>pp</sub>
MISCELLANEOUS PERFORMANCE	•				•	
Input Capacitance		1.0				pF
Output Resistance		10				Ω
Output Inductance		6				nH

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" specifies conditions of device operation.

Note 2: Min/max ratings are based on product characterization and simulation. Individual parameters are tested as noted. Outgoing quality levels are determined from tested parameters.

Note 3: Spec is 100% tested at +25°C

Note 4: Measured between the 20% and 80% levels of the waveform.

**Note 5:** Measured with both outputs driving  $150\Omega$ , AC coupled at 270 Mbps.

## Operation 询 CLC007\_07"供应商

### INPUT INTERFACING

The CLC007 has high impedance, emitter-follower buffered, differential inputs. Single-ended signals may also be input. Transmission lines supplying input signals must be properly terminated close to the CLC007. Either A.C. or D.C. coupling as in *Figure 2* or *Figure 3* may be used. *Figures 2*, 4 and

Figure 5 show how Thevenin-equivalent resistor networks are used to provide input termination and biasing. The input D.C. common-mode voltage range is 0.8V to 2.5V below the positive power supply ( $V_{\rm CC}$ ). Input signals plus bias should be kept within the specified common-mode range. For an 800 mV<sub>P-P</sub> input signal, typical input bias levels range from 1.2V to 2.1V below the positive supply.

Load Type	Resistor to V <sub>CC</sub> (R1)	Resistor to V <sub>EE</sub> (R2)
ECL, $50\Omega$ , $5V$ , $V_T=2V$	82.5Ω	124Ω
ECL, 50Ω, 5.2V, V <sub>T</sub> =2V	80.6Ω	133Ω
ECL, $75\Omega$ , 5V, $V_T=2V$	124Ω	187Ω
ECL, 75Ω, 5.2V, V <sub>T</sub> =2V	121Ω	196Ω
800 mV <sub>P-P</sub> , 50Ω, 5V, V <sub>T</sub> =1.6V	75.0Ω	154Ω
800 mV <sub>P-P</sub> , 75Ω, 5V, V <sub>T</sub> =1.6V	110Ω	232Ω
800 mV <sub>P-P</sub> , 2.2 KΩ, 5V, V <sub>T</sub> =1.6V	3240Ω	6810Ω

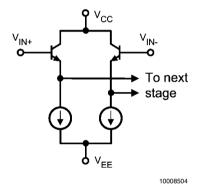


FIGURE 1. Input Stage

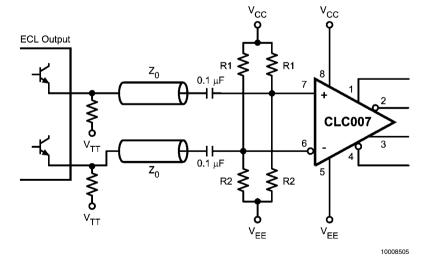


FIGURE 2. AC Coupled Input

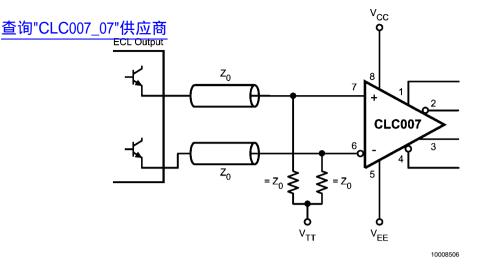


FIGURE 3. DC Coupled Input

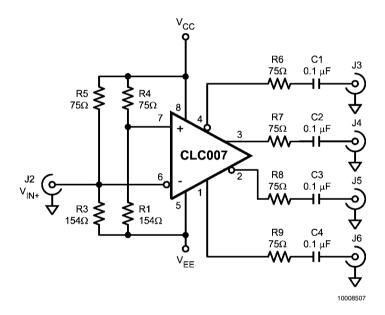


FIGURE 4. Single Ended  $50\Omega$  ECL Input

5

## 查询"CLC007\_07"供应商

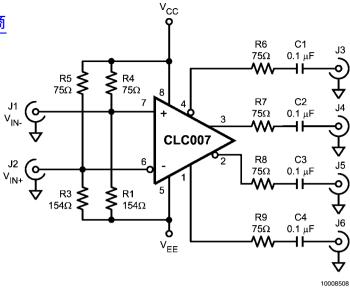


FIGURE 5. Differential  $50\Omega$  ECL Input

### **OUTPUT INTERFACING**

The CLC007's class AB output stage, *Figure 6*, requires no standing current in the output transistors and therefore requires no biasing or pull-down resistors. Advantages of this arrangement are lower power dissipation and fewer external components. The output may be either D.C. or A.C. coupled to the load. A bandgap voltage reference sets output voltage levels which are compatible with F100K and 10K ECL when

correctly terminated. The outputs do not have the same output voltage temperature coefficient as 10K. Therefore, noise margins will be reduced over the full temperature range when driving 10K ECL. Noise margins will not be affected when interfacing to F100K since F100K is fully voltage and temperature compensated.

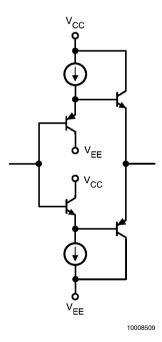


FIGURE 6. Output Stage

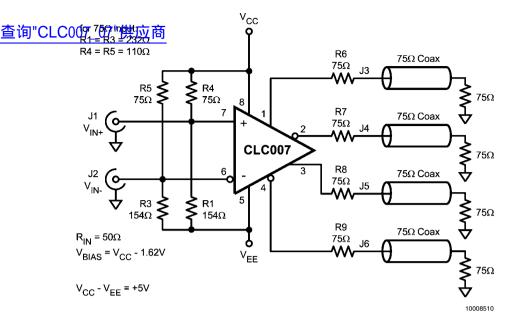


FIGURE 7. Differential Input DC Coupled Output

#### **OUTPUT RISE AND FALL TIMES**

Output load capacitance can significantly affect output rise and fall times. The effect of load capacitance, stray or otherwise, may be reduced by placing the output back-match resistor close to the output pin and by minimizing all interconnecting trace lengths. *Figure 8* shows the effect on risetime of parallel load capacitance across a 150 $\Omega$  load.

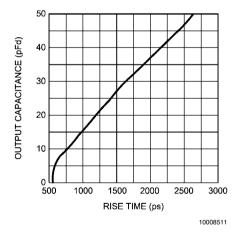


FIGURE 8. Rise Time vs C<sub>1</sub>

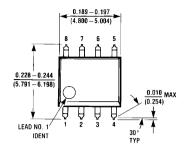
# **PCB Layout Recommendations**

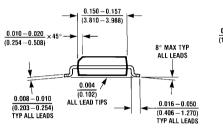
Printed circuit board layout affects the performance of the CLC007. The following guidelines will aid in achieving satisfactory device performance.

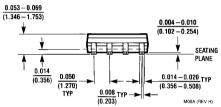
- Use a ground plane or power/ground plane sandwich design for optimum performance.
- Bypass device power with a 0.01 μF monolithic ceramic capacitor in parallel with a 6.8 μF tantalum electrolytic capacitor located no more than 0.1" (2.5 mm) from the device power pins.
- Provide short, symmetrical ground return paths for:

- inputs,
- supply bypass capacitors and
- the output load.
- · Provide short, grounded guard traces located
  - under the centerline of the package,
  - 0.1" (2.5 mm) from the package pins
  - on both top and bottom of the board with connecting vias.

## Physical Dimensions inches (millimeters) unless otherwise noted 查询"CLC007\_07"供应商







Order Number CLC007BM NS Package Number M08A

查询"CLC007_07"供应商	Notes	

查	
-	
	(((
	<u>本</u>

询"CLC007 07"供应商

**Notes** 

THE CONTENTS OF THIS DOCUMENT ARE PROVIDED IN CONNECTION WITH NATIONAL SEMICONDUCTOR CORPORATION ("NATIONAL") PRODUCTS. NATIONAL MAKES NO REPRESENTATIONS OR WARRANTIES WITH RESPECT TO THE ACCURACY OR COMPLETENESS OF THE CONTENTS OF THIS PUBLICATION AND RESERVES THE RIGHT TO MAKE CHANGES TO SPECIFICATIONS AND PRODUCT DESCRIPTIONS AT ANY TIME WITHOUT NOTICE. NO LICENSE, WHETHER EXPRESS. IMPLIED, ARISING BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT.

TESTING AND OTHER QUALITY CONTROLS ARE USED TO THE EXTENT NATIONAL DEEMS NECESSARY TO SUPPORT NATIONAL'S PRODUCT WARRANTY. EXCEPT WHERE MANDATED BY GOVERNMENT REQUIREMENTS, TESTING OF ALL PARAMETERS OF EACH PRODUCT IS NOT NECESSARILY PERFORMED. NATIONAL ASSUMES NO LIABILITY FOR APPLICATIONS ASSISTANCE OR BUYER PRODUCT DESIGN. BUYERS ARE RESPONSIBLE FOR THEIR PRODUCTS AND APPLICATIONS USING NATIONAL COMPONENTS. PRIOR TO USING OR DISTRIBUTING ANY PRODUCTS THAT INCLUDE NATIONAL COMPONENTS, BUYERS SHOULD PROVIDE ADEQUATE DESIGN, TESTING AND OPERATING SAFEGUARDS.

EXCEPT AS PROVIDED IN NATIONAL'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, NATIONAL ASSUMES NO LIABILITY WHATSOEVER, AND NATIONAL DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY RELATING TO THE SALE AND/OR USE OF NATIONAL PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

#### LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS PRIOR WRITTEN APPROVAL OF THE CHIEF EXECUTIVE OFFICER AND GENERAL COUNSEL OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

Life support devices or systems are devices which (a) are intended for surgical implant into the body, or (b) support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in a significant injury to the user. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system or to affect its safety or effectiveness.

National Semiconductor and the National Semiconductor logo are registered trademarks of National Semiconductor Corporation. All other brand or product names may be trademarks or registered trademarks of their respective holders.

Copyright@ 2007 National Semiconductor Corporation

For the most current product information visit us at www.national.com



National Semiconductor **Americas Customer** Support Center Email: new.feedback@nsc.com Tel: 1-800-272-9959

National Semiconductor Europe Customer Support Center Fax: +49 (0) 180-530-85-86 Email: europe.support@nsc.com Deutsch Tel: +49 (0) 69 9508 6208 English Tel: +49 (0) 870 24 0 2171 Français Tel: +33 (0) 1 41 91 8790 National Semiconductor Asia Pacific Customer Support Center Email: ap.support@nsc.com

National Semiconductor Japan Customer Support Center Fax: 81-3-5639-7507 Email: jpn.feedback@nsc.com Tel: 81-3-5639-7560